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# TECHNICAL REPORT



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**Safety of laser products –  
Part 13: Measurements for classification of laser products**

INTERNATIONAL  
ELECTROTECHNICAL  
COMMISSION

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## CONTENTS

FOREWORD.....	4
1 Scope.....	6
2 Normative references .....	6
3 Terms and definitions .....	6
4 Applicability.....	8
4.1 General.....	8
4.2 Initial considerations .....	8
5 Instrumentation requirements .....	9
6 Classification flow.....	10
7 Parameters for calculation of accessible emission limits.....	12
7.1 Wavelength ( $\lambda$ ).....	12
7.1.1 Wavelength determination .....	12
7.1.2 Ocular hazard regions .....	14
7.2 Multiple wavelength sources.....	14
7.2.1 General .....	14
7.2.2 Single hazard region.....	15
7.2.3 Two or more hazard regions .....	15
7.3 Spectrally broad sources .....	15
7.3.1 General .....	15
7.3.2 Spectral regions with small variation of the AEL with wavelength.....	15
7.3.3 Spectral regions with large variation of the AEL with wavelength (302,5 nm - 315 nm, 450 nm – 600 nm and 1 150 nm – 1 200 nm).....	16
7.3.4 Spectral regions containing hazard-type boundaries (near 400 nm and 1 400 nm) .....	16
7.3.5 Very broad sources .....	16
7.4 Source temporal characteristics .....	17
7.4.1 General .....	17
7.4.2 Sources with limited “ON” time .....	17
7.4.3 Periodic or constant duty factor sources .....	17
7.4.4 Sources with amplitude variation .....	19
7.4.5 Sources with varying pulse durations or irregular pulses.....	20
7.5 Angular subtense ( $\alpha$ ).....	20
7.5.1 General .....	20
7.5.2 Location of the reference point .....	22
7.5.3 Methods for determining angular subtense ( $\alpha$ ).....	23
7.5.4 Multiple sources and simple non-circular beams .....	26
7.6 Emission duration.....	31
7.6.1 General .....	31
7.6.2 Pulse duration .....	31
7.6.3 Pulse repetition frequency .....	31
7.7 Measurement conditions.....	31
7.7.1 General .....	31
7.7.2 Measurement conditions for classification.....	31
7.7.3 Measurement conditions for hazard evaluation .....	33
7.8 Scanning beams.....	36
7.8.1 General .....	36

7.8.2	Stationary angular subtense ( $\alpha_s$ ) .....	36
7.8.3	Scanned pulse duration ( $T_p$ ) .....	37
7.8.4	Scanning angular subtense ( $\alpha_{scan}$ ) .....	38
7.8.5	Bi-directional scanning .....	39
7.8.6	Number of scan lines in aperture ( $n$ ) .....	39
7.8.7	Maximum hazard location .....	40
7.8.8	Gaussian beam coupling parameter ( $\eta$ ) .....	41
7.8.9	Scan angle multiplication factor .....	41
Annex A (informative)	Examples .....	43
Annex B (informative)	Useful conversions .....	64
Bibliography	.....	65
Figure 1	– Continuous wave laser classification flow .....	11
Figure 2	– Pulsed laser classification flow .....	12
Figure 3	– Important wavelengths and wavelength ranges .....	13
Figure 4	– Pulse duration definition .....	18
Figure 5	– Flat-topped and irregular pulses .....	20
Figure 6	– Angular subtense .....	21
Figure 7	– Location of beam waist for a Gaussian beam .....	23
Figure 8a	– Measurement set-up with source imaging .....	24
Figure 8b	– Measurement set-up for accessible source .....	26
Figure 8	– Apparent source measurement set-ups .....	26
Figure 9	– Linear array apparent source size .....	27
Figure 10	– Measurement geometries .....	29
Figure 11	– Effective angular subtense of a simple non-circular source .....	30
Figure 12	– Imaging a stationary apparent source located beyond the scanning beam vertex .....	37
Figure 13	– Imaging a scanning apparent source located beyond the scanning beam vertex .....	37
Figure 14	– Scanning mirror with an arbitrary scan angle multiplication factor .....	42
Figure A.1	– Multiple raster lines crossing the measurement aperture at distance from scanning vertex where $C_6 = 1$ .....	49
Table 1	– Reference points .....	22
Table 2	– Four source array .....	28
Table A.1	– Number of source cases .....	62
Table A.2	– Number of source cases .....	63

## INTERNATIONAL ELECTROTECHNICAL COMMISSION

### SAFETY OF LASER PRODUCTS –

#### Part 13: Measurements for classification of laser products

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IEC 60825-13, which is a technical report, has been prepared by IEC technical committee 76: Optical radiation safety and laser equipment.

This second edition cancels and replaces the first edition of IEC 60825-13, published in 2006. It constitutes a technical revision.

The main changes with respect to the previous edition are as follows:

Minor changes and additions have been made in the definitions, classification flow has been updated, apparent source sections have been clarified, scanning has been updated, and more examples and useful conversions have been added to the annexes.

The text of this technical report is based on the following documents:

Enquiry draft	Report on voting
76/424/DTR	76/447/RVC

Full information on the voting for the approval of this technical report can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

This technical report is to be used in conjunction with IEC 60825-1:2007.

A list of all parts of the IEC 60825 series, published under the general title *Safety of laser products*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

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## **SAFETY OF LASER PRODUCTS –**

### **Part 13: Measurements for classification of laser products**

#### **1 Scope**

This part of IEC 60825 provides manufacturers, test houses, safety personnel, and others with practical guidance on methods to perform radiometric measurements or analyses to establish the emission level of laser energy in accordance with IEC 60825-1:2007 (herein referred to as “the standard”). The measurement procedures described in this technical report are intended as guidance for classification of laser products in accordance with that standard. Other procedures are acceptable if they are better or more appropriate.

Information is provided for calculating accessible emission limits (AELs) and maximum permissible exposures (MPEs), since some parameters used in calculating the limits are dependent upon other measured quantities.

This document is intended to apply to lasers, including extended sources and laser arrays. Users of this document should be aware that the procedures described herein for extended source viewing conditions may yield more conservative results than when using more rigorous methods.

NOTE Work continues on more complex source evaluations and will be provided as international agreement on the methods is reached.

#### **2 Normative references**

The following referenced document is indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60825-1:2007, *Safety of laser products – Part 1: Equipment classification and requirements*